## ELECTRONFORMATION DISCLOSURE STATEMENT

Electronic Version v18
Stylesheet Version v18.0

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## Title of Invention

Enhanced measurement of azimuthal dependence of subterranean parameters

Application Number:

10/827134

Confirmation Number:

2314

First Named Applicant:

Samuel Haugland

Attorney Docket Number: PAT035US

Art Unit:

2862 2851

Examiner:

Donald J McElheney

Search string:

( 4642648 or 4562556 or 5506769 or 5672867 or 5680906 or

6023658 or 6510106 ).pn.

## **US Patent Documents**

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

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## Signature

Examiner Name		Date
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						First Named Inventor			S. Mark Haugland		
						Art Unit Examiner Name			285/		
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¹Applicant	is to pla	ce a che	eck mark here if English lang	juage T	ranslation	ı is at	tached.				